PATENT APPLICATION

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of

Takuya TSUKAGOSHI et al.

Application No.:   New U.S. National Stage of PCT/JP2004/012850

Filed: April 26, 2006   Docket No.: 127848

For: MULTILAYER HOLOGRAPHIC RECORDING MEDIUM AND MANUFACTURING
        METHOD OF THE SAME, MULTILAYER HOLOGRAPHIC RECORDING AND
        REPRODUCING METHOD, MULTILAYER HOLOGRAPHIC MEMORY
        REPRODUCING APPARATUS, AND MULTILAYER HOLOGRAPHIC RECORDING
        AND REPRODUCING APPARATUS

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

        Pursuant to 37 CFR §1.56, the attention of the Patent and Trademark Office is hereby
directed to the references listed on the attached PTO-1449. Unless otherwise indicated herein,
one copy of each reference is attached. It is respectfully requested that the information be
expressly considered during the prosecution of this application, and that the references be made
of record therein and appear among the "References Cited" on any patent to issue therefrom.

☒   1.   This Information Disclosure Statement is being filed (a) within three months of
              the U.S. filing date of this non-CPA application, OR (b) before the mailing date of a first
              Office Action on the merits in the present application. No certification or fee is required.

☒   2.   Relevance of one or more non-English language reference is discussed in the
              present specification. See Reference 3.

☒   3.   One or more reference cited herein was cited in the International Search Report.
              An English language version of the International Search Report is attached for the
              Examiner's information. See References 4-6.

☒   4.   In accordance with 37 CFR §1.98(a)(2)(ii), copies of any U.S. patents and patent
              application publications are not attached.

☒   5.   An English language Abstract of one or more non-English language reference is
              attached hereto. See References 3-6.

ALL REFERENCES CONSIDERED EXCEPT WHERE LINED THROUGH. /F.A./

☒ 6.   A computer-generated English language translation of one or more Japanese
Patent Publication cited herein has been obtained from the website of the Japanese Patent
Office ([http://www.jpo.go.jp]), and is attached, but has not been reviewed for accuracy.
See References 3-6.

10577245 - GAU: 2872

☒ 7.   References 1 and 2 correspond to reference 4.

Respectfully submitted,

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JAO:DAT/per

Date: April 26, 2006

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Form PTO-1449 (REV. 1/06)	US Dept. of Commerce PATENT & TRADEMARK OFFICE	ATTY DOCKET NO. 127848	APPLICATION NO. New U.S. National Stage of PCT/JP2004/012850
INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary)		APPLICANTS Takuya TSUKAGOSHI et al.	
		FILING DATE April 26, 2006	

U.S. PATENT DOCUMENTS

Examiner Initials	Cite No.	Document Number	Date	Name
	1.	5,755,919	5/26/1998	Ueda et al.
	2.	5,993,600	11/30/1999	Ueda et al.

FOREIGN PATENT DOCUMENTS

Examiner Initials	Cite No.	Document Number	Date	Country	With English Abstract	With English Translation
	3.	JP A 2000-149318	5/30/2000	JAPAN	X	X
	4.	JP A 8-220976	8/30/1996	JAPAN	X	X
	5.	JP A 6-195019	7/15/1994	JAPAN	X	X
	6.	JP A 11-224043	8/17/1999	JAPAN	X	X

OTHER DOCUMENTS

Examiner Initials	Cite No.	(Including Author, Title, Date, Pertinent Pages, etc.)

EXAMINER /Fayez Assaf/	DATE CONSIDERED 09/28/2008

Examiner: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Date: April 26, 2006 ALL REFERENCES CONSIDERED EXCEPT WHERE LINED THROUGH. /F.A./